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Report No.: SZEM140300122004

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## SAR Evaluation Report

**Application No.:** SZEM1403001220RF  
**Applicant:** Quintic (Beijing) Microelectronics Co., Ltd.  
**Manufacturer:** Quintic (Beijing) Microelectronics Co., Ltd.  
**Factory:** Quintic (Beijing) Microelectronics Co., Ltd.  
**Product Name:** Bluetooth 4.0 Low Energy Module  
**Model No.(EUT):** QS9321-PLCS  
**Trade Mark:** Quintic  
**FCC ID:** 2AB359321-0B  
**Standards:** 47 CFR Part 1.1307(2013)  
47 CFR Part 2.1093 (2013)  
KDB447498D01 General RF Exposure Guidance v05  
**Date of Receipt:** 2014-03-21  
**Date of Test:** 2014-04-03 to 2014-04-04  
**Date of Issue:** 2014-12-16

<b>Test Result :</b>	<b>PASS*</b>
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\* In the configuration tested, the EUT complied with the standards specified above.

This report supersedes our previous report SZEM140300122002, issued on 2014-04-06, which is hereby deemed null and void.

Authorized Signature:



Jack Zhang  
EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report.

If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the federal government. All test results in this report can be traceable to National or International Standards.

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### 3 General Information

#### 3.1 Client Information

Applicant:	Quintic (Beijing) Microelectronics Co., Ltd.
Address of Applicant:	301A Building B, SP Tower, Tsinghua Science Park, Beijing 100084 P.R.China
Manufacturer:	Quintic (Beijing) Microelectronics Co., Ltd.
Address of Manufacturer:	301A Building B, SP Tower, Tsinghua Science Park, Beijing 100084 P.R.China
Factory:	Quintic (Beijing) Microelectronics Co., Ltd.
Address of Factory:	301A Building B, SP Tower, Tsinghua Science Park, Beijing 100084 P.R.China

#### 3.2 General Description of EUT

Product Name:	Bluetooth 4.0 Low Energy Module
Model No.:	QS9321-PLCS
Trade Mark:	Quintic
Operation Frequency:	2402MHz~2480MHz
Bluetooth Version:	4.0 BLE
Modulation Type:	GFSK
Number of Channel:	40
Test Power Grade:	4 (manufacturer declare)
Test Software of EUT:	N/A
Antenna Type:	Integral
Antenna Gain:	2.21dBi
Power Supply:	3.0V DC(3.0*1V "CR2032" Button Cell)

#### 3.3 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch E&E Lab

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China  
518057

Telephone: +86 (0) 755 2601 2053 Fax: +86 (0) 755 2671 0594

No tests were sub-contracted.



### **3.4 Test Facility**

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L2929)**

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **VCCI**

The 3m Semi-anechoic chamber, Full-anechoic Chamber and Shielded Room (7.5m x 4.0m x 3.0m) of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-2197, G-416, T-1153 and C-2383 respectively.

- **FCC – Registration No.: 556682**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No.: 556682.

- **Industry Canada (IC)**

Two 3m Semi-anechoic chambers of SGS-CSTC Standards Technical Services Co., Ltd. have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1 & 4620C-2.

### **3.5 Deviation from Standards**

None.

### **3.6 Abnormalities from Standard Conditions**

None.

### **3.7 Other Information Requested by the Customer**

None.



## 4 SAR Evaluation

### 4.1 RF Exposure Compliance Requirement

#### 4.1.1 Standard Requirement

According to KDB447498D01 General RF Exposure Guidance v05

##### 4.3.1. Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Exclusion Threshold condition, listed below, is satisfied.

#### 4.1.2 Limits

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances  $\leq 50$  mm are determined by:

$$\left[ \frac{(\text{max. power of channel, including tune-up tolerance, mW})}{(\text{min. test separation distance, mm})} \right] \cdot \sqrt{f(\text{GHz})} \leq 3.0 \text{ for 1-g SAR and } \leq 7.5 \text{ for 10-g extremity SAR, where}$$

$f(\text{GHz})$  is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation<sup>17</sup>

The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is  $\leq 50$  mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is  $< 5$  mm, a distance of 5 mm is applied to determine SAR test exclusion

#### 4.1.3 EUT RF Exposure

The Max Conducted Peak Output Power is 1.34dBm in highest channel(2.480GHz);

The best case gain of the antenna is 2.21dBi.

$\text{EIRP} = 1.34\text{dBm} + 2.21\text{dBi} = 3.55\text{dBm}$

3.55dBm logarithmic terms convert to numeric result is nearly 2.2646mW

According to the formula. calculate the EIRP test result:

$$\left[ \frac{(\text{max. power of channel, including tune-up tolerance, mW})}{(\text{min. test separation distance, mm})} \right] \cdot \sqrt{f(\text{GHz})}$$

General RF Exposure =  $(2.2646\text{mW} / 5 \text{ mm}) \times \sqrt{2.480\text{GHz}} = 0.7133$  ①

SAR requirement:

$S = 3.0$

② ;

① < ②.

So the SAR report is not required.